



Test Certificate

A sample of the following product received on September 13, 2010 and tested on September 22, 2010 complied with the requirements of,

- Subpart B of Part 15 of FCC Rules for Class B digital devices
- Industry Canada Interference Causing Equipment Standard ICES 003, dated February 2004 (Class B)

given the measurement uncertainties detailed in Elliott report R80789.

Intel Corporation
Model Intel® Centrino® Advanced-N 6230 (model 62230HMW)

Mark Briggs
Mark Briggs
Staff Engineer

Intel Corporation

Printed Name



Testing Cert #2016.01

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EMC Test Report

Class B Information Technology Equipment

*FCC Part 15
Industry Canada ICES 003*

*Model: Intel® Centrino® Advanced-N 6230 (model
62230HMW)*

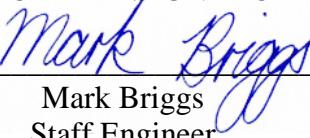
COMPANY: Intel Corporation
100 Center Point Circle Suite 200
Columbia, SC 29210

TEST SITE(S): Elliott Laboratories
41039 Boyce Road.
Fremont, CA. 94538-2435

REPORT DATE: October 11, 2010

FINAL TEST DATES: September 22, 2010

AUTHORIZED SIGNATORY:



Mark Briggs
Staff Engineer
Elliott Laboratories, An NTS Company



Testing Cert #2016.01

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REVISION HISTORY

Rev#	Date	Comments	Modified By
-	10-11-2010	First release	

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SCOPE

Governments and standards organizations around the world have published requirements regarding the electromagnetic compatibility (EMC) of electronic equipment. Testing has been performed on the Intel Corporation model Intel® Centrino® Advanced-N 6230 (model 62230HMW), pursuant to the following standards.

Standard	Title	Standard Date
FCC Part 15, Subpart B	Radio Frequency Devices	October 2009 as Amended
ICES-003, Issue 4	Digital apparatus	2004

All measurements and evaluations have been in accordance with these specifications, test procedures, and measurement guidelines as outlined in Elliott Laboratories test procedures, and in accordance with the standards referenced therein.

OBJECTIVE

The objective of Intel Corporation is to verify compliance with FCC requirements for digital devices and Canada's requirements for digital devices.

STATEMENT OF COMPLIANCE

The tested sample of Intel Corporation model Intel® Centrino® Advanced-N 6230 (model 62230HMW) complied with the requirements of:

Standard/Regulation	Equipment Type/Class	Standard Date
Subpart B of Part 15 of the FCC Rules (CFR title 47)	Class B	2009 as amended
ICES-003, Issue 4	Class B	2004

The test results recorded herein are based on a single type test of the Intel Corporation model Intel® Centrino® Advanced-N 6230 (model 62230HMW) and therefore apply only to the tested sample(s). The sample was selected and prepared by Steve Hackett of Intel Corporation.

Maintenance of compliance is the responsibility of the company. Any modification of the product that could result in increased emissions or susceptibility should be checked to ensure compliance has been maintained (i.e., printed circuit board layout changes, different enclosure, different line filter or power supply, harnessing and/or interface cable changes, etc.).

DEVIATIONS FROM THE STANDARDS

No deviations were made from the published requirements listed in the scope of this report.

INFORMATION TECHNOLOGY EQUIPMENT EMISSIONS TEST RESULTS

The following emissions tests were performed on the Intel Corporation model Intel® Centrino® Advanced-N 6230 (model 62230HMW). The measurements were extracted from the data recorded during testing and represent the highest amplitude emissions relative to the specification limits. The complete test data is provided in the appendices of this report.

CONDUCTED EMISSIONS (MAINS PORT)

Frequency Range Operating Voltage	Standard/Section	Requirement	Measurement	Margin	Status
0.15-30 MHz, 120V, 60Hz	FCC § 15.107(a) (Class B)	0.15-0.5 MHz: 66-56 dB μ V QP 56-46 dB μ V Av 0.5-5.0 MHz: 56 dB μ V QP 46 dB μ V Av 5.0-30.0 MHz: 60 dB μ V QP 50 dB μ V Av	44.7dB μ V @ 1.900MHz	-11.3dB	Complied

RADIATED EMISSIONS

Frequency Range	Standard/Section	Requirement	Measurement	Margin	Status
30-1000 MHz	FCC §15.109(g) Class B	30 – 230, 30 dB μ V/m 230 – 1000, 37 dB μ V/m (10m limit)	32.7dB μ V/m @60.01 MHz	-7.3dB	Complied

Note 1 Testing above 1GHz against FCC 15.109(a) requirements was not required because the highest frequency generated in the EUT's digital circuitry (40MHz) was less than 108 MHz.

MEASUREMENT UNCERTAINTIES

ISO/IEC 17025 requires that an estimate of the measurement uncertainties associated with the emissions test results be included in the report. The measurement uncertainties given below were calculated using the approach described in CISPR 16-4-2:2003 using a coverage factor of $k=2$, which gives a level of confidence of approximately 95%. The levels were found to be below levels of U_{cispr} and therefore no adjustment of the data for measurement uncertainty is required.

Measurement Type	Measurement Unit	Frequency Range	Expanded Uncertainty
Conducted Emissions	dB μ V or dB μ A	150kHz – 30MHz	± 2.2 dB
Radiated Electric Field	dB μ V/m	30 – 1000 MHz 1000 – 40,000 MHz	± 3.6 dB ± 6.0 dB

EQUIPMENT UNDER TEST (EUT) DETAILS**GENERAL**

The Intel Corporation model Intel® Centrino® Advanced-N 6230 (model 62230HMW) is a PCIe half mini card form factor Bluetooth/IEEE 802.11a/b/g/n wireless network adapter. The card supports MIMO (2x2) for 802.11n modes and MISO (1x2) for 802.11a/b/g modes. Bluetooth only operation mode is a 1x1. When Bluetooth is operational then 802.11b/g/n modes operate as SISO (1x1). 802.11a/n modes still operate as MIMO (2x2) with Bluetooth operational.

The card is sold under two different FCC/IC ID numbers (see table below). The ID's ending in "U" are intended to allow user install conditions and host systems must be provided with a BIOS locking feature that prevents installation of unauthorized devices.

For radio testing purposes the card was installed in a test fixture that exposed all sides of the card. For digital device testing for certification under equipment code JBP the card was installed inside a laptop PC.

The sample was received on September 13, 2010 and tested on September 22, 2010. The EUT consisted of the following component(s):

Manufacturer	Model	Description	MAC Address	FCC ID and Canada UPN
Intel Corporation	62230ANHMW	PCIe Half Mini Card form factor Bluetooth / IEEE 802.11a/b/g/n wireless network adapter	00150079AD10	PD962230ANH PD962230ANHU 1000M-62230ANH
	62230ANHU			1000M-62230ANHU

ENCLOSURE

The EUT does not have an enclosure as it is designed to be installed within the enclosure of a host computer or system.

MODIFICATIONS

No modifications were made to the EUT during the time the product was at Elliott.

SUPPORT EQUIPMENT

The EUT was installed inside the laptop during testing. The following equipment was used as remote support equipment for testing:

Company	Model	Description	Serial Number	FCC ID
Toshiba	Satellite	Laptop (Host)		
HP	Deskjet 5650	Printer	MY3883K442P	DoC
EUT was installed inside the Laptop				

Company	Model	Description	Serial Number	FCC ID
D-Link	DES-1105	Hub	DRL7271011218	-

EUT INTERFACE PORTS

The I/O cabling configuration during emissions testing was as follows:

Port From	To	Description	Cable(s) Shielded/Unshielded	Length(m)
Ethernet (Host)	Router	Cat 5	Unshielded	10
USB (Host)	Printer	USB	Shielded	1
AC/DC Adapter (Host)	AC Mains	2 wire/ 3wire	Unshielded	1.0/ 1.0

EUT OPERATION

During emissions testing the digital interface to the EUT was active, the laptop was showing a scrolling H pattern and the peripheral interfaces were enabled and active. The EUT (installed inside the system) was actively searching for a network.

EMISSIONS TESTING**GENERAL INFORMATION**

Final test measurements were taken at the Elliott Laboratories Anechoic Chambers and/or Open Area Test Site(s) listed below. The test sites contain separate areas for radiated and conducted emissions testing. The sites conform to the requirements of ANSI C63.4: 2003 *American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz* and CISPR 16-1-4:2007 - *Specification for radio disturbance and immunity measuring apparatus and methods Part 1-4: Radio disturbance and immunity measuring apparatus Ancillary equipment Radiated disturbances*. They are registered with the VCCI and are on file with the FCC and industry Canada.

Site	Registration Numbers			Location
	VCCI	FCC	Canada	
Chamber 3	R-1683 G-58 C-1795 T-1639	769238	IC 2845B-3	41039 Boyce Road Fremont, CA 94538-2435

Considerable engineering effort has been expended to ensure that the facilities conform to all pertinent requirements.

Emissions measurements were made with the EUT powered from a supply voltage within the expected tolerances of each nominal operating voltage/frequency for each geographical regions covered by the scope of the standards referenced in this report.

CONDUCTED EMISSIONS CONSIDERATIONS

Conducted emissions testing is performed in conformance with ANSI C63.4 and CISPR 22.

Mains port measurements are made with the EUT connected to the public power network through nominal, standardized RF impedance, which is provided by a line impedance stabilization network, known as a LISN. A LISN is inserted in series with each current-carrying conductor in the EUT power cord.

Telecommunication port measurements are made with the network cable connected through an ISN appropriate to the type of cable employed.

RADIATED EMISSIONS CONSIDERATIONS

The FCC has determined that radiated measurements made in a non-anechoic shielded enclosure are not suitable for determining levels of radiated emissions. Radiated measurements are performed in an Open Area Test Site or semi-anechoic chamber, as defined in ANSI C63.4. The test site is maintained free of conductive objects within the CISPR defined elliptical area incorporated in ANSI C63.4 guidelines.

MEASUREMENT INSTRUMENTATION**RECEIVER SYSTEM**

An EMI receiver as specified in CISPR 16-1-1:2006 is used for emissions measurements. The receivers used can measure over the frequency range of 9 kHz up to 7 GHz. These receivers allow both ease of measurement and high accuracy to be achieved. The receivers have Peak, Average, and CISPR (Quasi-peak) detectors built into their design so no external adapters are necessary. The receiver automatically sets the required bandwidth for the CISPR detector used during measurements.

For measurements above the frequency range of the receivers, a spectrum analyzer is utilized because it provides visibility of the entire spectrum along with the precision and versatility required to support engineering analysis. Average measurements above 1000 MHz are performed on the spectrum analyzer using the linear-average method with a resolution bandwidth of 1 MHz and a video bandwidth of 10 Hz.

INSTRUMENT CONTROL COMPUTER

The receivers utilize either a Rohde & Schwarz EZM Spectrum Monitor/Controller or contain an internal Spectrum Monitor/Controller to view and convert the receiver measurements to the field strength at an antenna or voltage developed at the LISN measurement port, which is then compared directly with the appropriate specification limit. This provides faster, more accurate readings by performing the conversions described under Sample Calculations within the Test Procedures section of this report. Results are printed in a graphic and/or tabular format, as appropriate. A personal computer is used to record all measurements made with the receivers.

The Spectrum Monitor provides a visual display of the signal being measured. In addition, the controller or a personal computer runs automated data collection programs that control the receivers. This provides added accuracy since all site correction factors, such as cable loss and antenna factors are added automatically.

LINE IMPEDANCE STABILIZATION NETWORK (LISN)

Line conducted emission measurements utilize a fifty micro-Henry Line Impedance Stabilization Network as the monitoring point. The LISN used also contains a 250-uH CISPR adapter. This network provides for calibrated radio-frequency noise measurements by the design of the internal low-pass and high-pass filters on the EUT and measurement ports, respectively.

FILTERS/ATTENUATORS

External filters and precision attenuators are often connected between the receiving antenna or LISN and the receiver. This eliminates saturation effects and non-linear operation due to high-amplitude transient events.

ANTENNAS

A biconical antenna is used to cover the range from 30 MHz to 300 MHz and a log periodic antenna is utilized from 300 MHz to 1000 MHz. Narrowband tuned dipole antennas are used over the entire 30 to 1000 MHz frequency range for precision measurements of field strength. Above 1000 MHz, a horn antenna is used. The antenna calibration factors are included in site factors that are programmed into the test receivers.

ANTENNA MAST AND EQUIPMENT TURNTABLE

The antennas used to measure the radiated electric field strength are mounted on a non-conductive antenna mast equipped with a motor drive to vary the antenna height.

ANSI C63.4 specifies that the test height above ground for table-mounted devices shall be 80 centimeters. Floor-mounted equipment shall be placed on the ground plane if the device is normally used on a conductive floor or separated from the ground plane by insulating material up to 12-mm thick if the device is normally used on a non-conductive floor. During radiated measurements, the EUT is positioned on a motorized turntable in conformance with this requirement.

INSTRUMENT CALIBRATION

All test equipment is regularly checked to ensure that performance is maintained in accordance with the company's specifications. All antennas are calibrated at regular intervals with respect to tuned half-wave dipoles. An appendix of this report contains the list of test equipment used and calibration information.

TEST PROCEDURES

EUT AND CABLE PLACEMENT

The standards require that interconnecting cables be connected to the available ports of the unit and that the placement of the unit and the attached cables simulate the worst case orientation that can be expected from a typical installation, so far as practicable. To this end, the position of the unit and associated cabling is varied within the guidelines of ANSI C63.4, and the worst-case orientation is used for final measurements.

CONDUCTED EMISSIONS (MAINS)

Conducted emissions are measured at the plug end of the power cord supplied with the EUT. Excess power cord length is wrapped in a bundle between 30 and 40 centimeters in length near the center of the cord. Preliminary measurements are made to determine the highest-amplitude emission relative to the specification limit for all the modes of operation. Placement of system components and varying of cable positions are performed in each mode. A final peak-mode scan is then performed in the position and mode for which the highest emission was noted on all current carrying conductors of the power cord. Emissions that have peak values close to the specification limit are also measured in the quasi-peak and average detection modes to determine compliance except when the amplitude of the emission when measured with the quasi-peak detector is more than 10 dB below the specification limit for average measurements. In this case only quasi-peak measurements are performed.

CONDUCTED EMISSIONS (TELECOMMUNICATION PORTS)

Conducted emissions voltages are measured at a point 80 cm from the EUT. If conducted emission currents are measured, the current probe is located 70 cm from the EUT. Preliminary measurements are made to determine the highest-amplitude emission relative to the specification limit for all the modes of operation. Placement of system components and varying of cable positions are performed in each mode. A final peak-mode scan is then performed in the position and mode for which the highest emission was noted. Emissions that have peak values close to the specification limit are also measured in the quasi-peak and average detection modes to determine compliance except when the amplitude of the emission when measured with the quasi-peak detector is more than 10 dB below the specification limit for average measurements. In this case only quasi-peak measurements are performed.

RADIATED EMISSIONS (SEMI-ANECHOIC and/or OATS TEST ENVIRONMENT)

Radiated emissions measurements in a semi-anechoic environment are performed in two phases (preliminary scan and final maximization). Final maximization may be performed on an OATS.

Preliminary Scan

A preliminary scan of emissions is conducted in which all significant EUT frequencies are identified with the system in a nominal configuration. At least two scans are performed from 30 MHz up to the frequency required by the regulations specified on page 1. One or more of these are performed with the antenna polarized vertically and one or more of these are performed with the antenna polarized horizontally. During the preliminary scans, the EUT is rotated through 360°, the antenna height is varied and cable positions are varied to determine the highest emission relative to the limit. A speaker is provided in the receiver to aid in discriminating between EUT and ambient emissions if required. Other methods used during the preliminary scan for EUT emissions involve scanning with near-field magnetic loops, monitoring I/O cables with RF current clamps, and cycling power to the EUT.

Final Maximization

During final maximization, the highest-amplitude emissions identified in the spectral search are viewed while the EUT azimuth angle is varied from 0 to 360 degrees relative to the receiving antenna. The azimuth that results in the highest emission is then maintained while varying the antenna height from one to four meters. The result is the identification of the highest amplitude for each of the highest peaks. Each recorded level is corrected in the receiver using appropriate factors for cables, connectors, antennas, and preamplifier gain. Emissions that have values close to the specification limit may also be measured with a tuned dipole antenna to determine compliance.

For measurements above 1GHz every effort is made to ensure the EUT remains within the cone of radiation of the measurement antenna (i.e. 3dB beam-width of the antenna). This may include rotating the product and/or angling the measurement antenna.

When Testing above 18 GHz, the receive antenna is located at 1 meter from the EUT and the antenna height is restricted to a maximum of 2.5m. Maximum emissions are found within this restricted range because emission levels decrease over distance and as the antenna is raised above 2.5m, the distance from the EUT increases. As a result of the increased measurement distance, at antenna heights above 2.5m, lower emission levels are measured as compared to emissions levels measured at antenna heights at 2.5m and below.

SAMPLE CALCULATIONS**SAMPLE CALCULATIONS - CONDUCTED EMISSIONS**

Receiver readings are compared directly to the conducted emissions specification limit (decibel form). The calculation is as follows:

$$R_r - S = M$$

where:

R_r = Receiver Reading in dBuV

S = Specification Limit in dBuV

M = Margin to Specification in +/- dB

SAMPLE CALCULATIONS - RADIATED EMISSIONS

Receiver readings are compared directly to the specification limit (decibel form). The receiver internally corrects for cable loss, preamplifier gain, and antenna factor. The calculations are in the reverse direction of the actual signal flow, thus cable loss is added and the amplifier gain is subtracted. The Antenna Factor converts the voltage at the antenna coaxial connector to the field strength at the antenna elements. A distance factor, when used for electric field measurements, is calculated by using the following formula:

$$F_d = 20 * \text{LOG10} (D_m / D_s)$$

where:

F_d = Distance Factor in dB

D_m = Measurement Distance in meters

D_s = Specification Distance in meters

Measurement Distance is the distance at which the measurements were taken and Specification Distance is the distance at which the specification limits are based. The Antenna Factor converts the voltage at the antenna coaxial connector to the field strength at the antenna elements.

The margin of a given emission peak relative to the limit is calculated as follows:

$$R_c = R_r + F_d$$

and

$$M = R_c - L_s$$

where:

R_r = Receiver Reading in dBuV/m

F_d = Distance Factor in dB

R_c = Corrected Reading in dBuV/m

L_s = Specification Limit in dBuV/m

M = Margin in dB Relative to Spec

*Appendix A Test Equipment Calibration Data***Conducted Emissions - AC Power Ports**

<u>Manufacturer</u>	<u>Description</u>	<u>Model</u>	<u>Asset #</u>	<u>Cal Due</u>
Rohde & Schwarz	Pulse Limiter	ESH3 Z2	372	2/3/2011
Solar Electronics	LISN	8028-50-TS-24-BNC support	904	3/2/2011
EMCO	LISN, 10 kHz-100 MHz	3825/2	1292	3/12/2011
Hewlett Packard	EMC Spectrum Analyzer, 9 KHz - 22 GHz	8593EM	1319	10/19/2010
Rohde & Schwarz	Test Receiver, 9 kHz-2750 MHz	ESCS 30	1337	11/11/2010

Radiated Emissions, 30 - 1,000 MHz

<u>Manufacturer</u>	<u>Description</u>	<u>Model</u>	<u>Asset #</u>	<u>Cal Due</u>
Hewlett Packard	EMC Spectrum Analyzer, 9 KHz - 22 GHz	8593EM	1319	10/19/2010
Rohde & Schwarz	Test Receiver, 9 kHz-2750 MHz	ESCS 30	1337	11/11/2010
Sunol Sciences	Biconilog, 30-3000 MHz	JB3	1548	6/24/2012
Com-Power Corp.	Preamplifier, 30-1000 MHz	PAM-103	2234	5/19/2011

Appendix B Test Data

T80540 7 Pages



EMC Test Data

Client:	Intel Corporation	Job Number:	J80398
Model:	Intel® Centrino® Advanced-N 6230	T-Log Number:	T80540
		Account Manager:	Christine Krebill
Contact:	Steve Hackett		-
Emissions Standard(s):	FCC 15.247	Class:	B
Immunity Standard(s):	-	Environment:	-

EMC Test Data

For The

Intel Corporation

Model

Intel® Centrino® Advanced-N 6230

Date of Last Test: 10/6/2010



EMC Test Data

Client:	Intel Corporation	Job Number:	J80398
Model:	Intel® Centrino® Advanced-N 6230	T-Log Number:	T80540
		Account Manager:	Christine Krebill
Contact:	Steve Hackett		
Standard:	FCC 15.247	Class:	B

Radiated Emissions - Digital Device (PC Peripheral)

(Elliott Laboratories Fremont Facility, Semi-Anechoic Chamber)

Test Specific Details

Objective: The objective of this test session is to perform final qualification testing of the EUT with respect to the specification listed above.

Date of Test: 9/22/2010
Test Engineer: Peter Sales
Test Location: Fremont Chamber #3

Config. Used: 1
Config Change: None
EUT Voltage: 120V/60Hz

General Test Configuration

The EUT and any local support equipment were located on the turntable for radiated emissions testing. Any remote support equipment was located outside the semi-anechoic chamber. Any cables running to remote support equipment were routed through metal conduit and when possible passed through a ferrite clamp upon exiting the chamber.

The test distance and extrapolation factor (if applicable) are detailed under each run description.

Note, preliminary testing indicates that the emissions were maximized by orientation of the EUT and elevation of the measurement antenna. Maximized testing indicated that the emissions were maximized by orientation of the EUT, elevation of the measurement antenna, and manipulation of the EUT's interface cables.

Ambient Conditions:

Temperature: 23 °C
Rel. Humidity: 48 %

Summary of Results

MAC Address: 00150079AD10 Driver version 14.0.0.39, EUT installed inside laptop

Run #	Test Performed	Limit	Result	Margin
1	Radiated Emissions 30 - 1000 MHz	FCC Class B	Pass	32.7dB μ V/m @ 60.01MHz (-7.3dB)

Modifications Made During Testing

No modifications were made to the EUT during testing

Deviations From The Standard

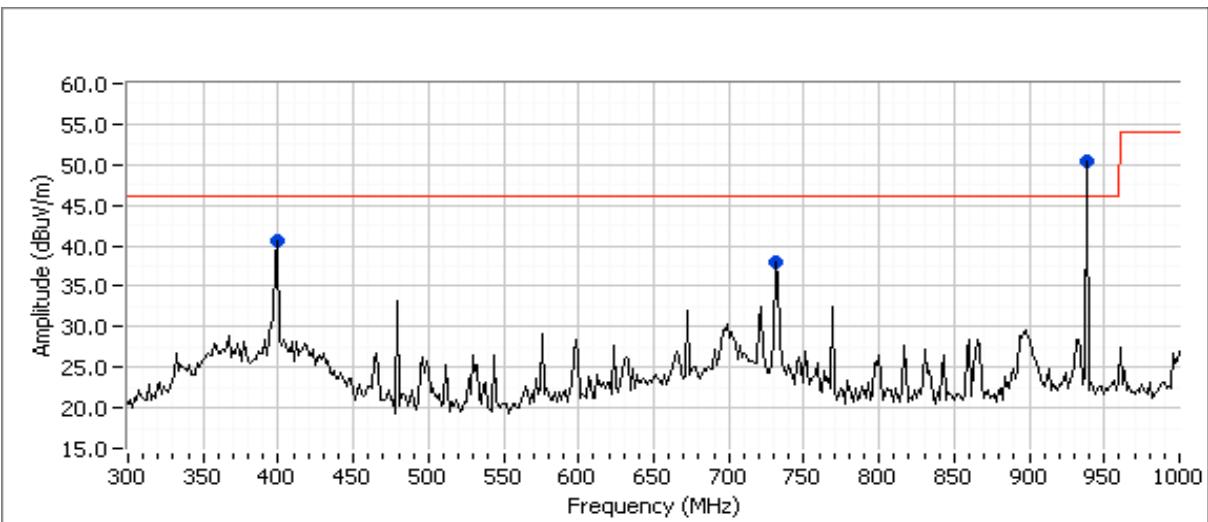
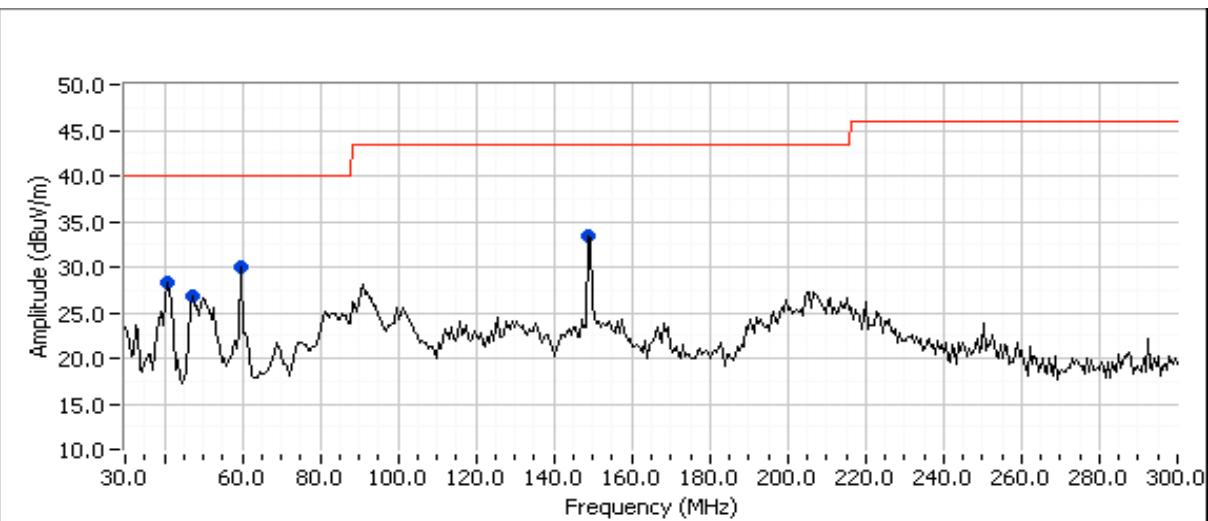
No deviations were made from the requirements of the standard.

Client: Intel Corporation	Job Number: J80398
Model: Intel® Centrino® Advanced-N 6230	T-Log Number: T80540
Contact: Steve Hackett	Account Manager: Christine Krebill
Standard: FCC 15.247	Class: B

Run #1: Preliminary Radiated Emissions, 30 - 1000 MHz

make sure test configuration information is completed in the sheet "Test Configuration JBP" - Laptop needs two peripherals connected

Frequency Range	Test Distance	Limit Distance	Extrapolation Factor
30 - 1000 MHz	3	3	0.0





EMC Test Data

Client:	Intel Corporation	Job Number:	J80398
Model:	Intel® Centrino® Advanced-N 6230	T-Log Number:	T80540
Contact:	Steve Hackett	Account Manager:	Christine Krebill
Standard:	FCC 15.247	Class:	B

Run #1: Continued

Preliminary peak readings captured during pre-scan

Frequency	Level	Pol	FCC Class B		Detector	Azimuth	Height	Comments
MHz	dB μ V/m	v/h	Limit	Margin	Pk/QP/Avg	degrees	meters	
933.456	50.5	H	46.0	4.5	Peak	162	4.0	
399.570	40.6	H	46.0	-5.4	Peak	175	1.0	
729.591	37.9	H	46.0	-8.1	Peak	223	1.0	
60.006	29.9	V	40.0	-10.1	Peak	214	1.0	
148.042	33.3	H	43.5	-10.2	Peak	340	3.0	
39.690	28.2	V	40.0	-11.8	Peak	246	1.5	
46.932	26.9	V	40.0	-13.1	Peak	259	1.0	

Preliminary quasi-peak readings (no manipulation of EUT interface cables)

Frequency	Level	Pol	FCC Class B		Detector	Azimuth	Height	Comments
MHz	dB μ V/m	v/h	Limit	Margin	Pk/QP/Avg	degrees	meters	
60.006	32.7	V	40.0	-7.3	QP	212	1.0	QP (1.00s)
399.570	34.0	H	46.0	-12.0	QP	177	1.0	QP (1.00s)
729.591	26.2	H	46.0	-19.8	QP	224	1.0	QP (1.00s)
46.932	17.1	V	40.0	-22.9	QP	257	1.0	QP (1.00s)
39.690	16.4	V	40.0	-23.6	QP	245	1.5	QP (1.00s)
933.456	17.0	H	46.0	-29.0	QP	163	4.0	QP (1.00s)
148.042	9.2	H	43.5	-34.3	QP	338	3.0	QP (1.00s)

Run #2: Maximized Readings From Run #1

Maximized quasi-peak readings (includes manipulation of EUT interface cables)

Frequency Range	Test Distance	Limit Distance	Extrapolation Factor
30 - 1000 MHz	3	3	0.0

Frequency	Level	Pol	FCC Class B		Detector	Azimuth	Height	Comments
MHz	dB μ V/m	v/h	Limit	Margin	Pk/QP/Avg	degrees	meters	
60.006	32.7	V	40.0	-7.3	QP	212	1.0	QP (1.00s)
399.570	34.0	H	46.0	-12.0	QP	177	1.0	QP (1.00s)
729.591	26.2	H	46.0	-19.8	QP	224	1.0	QP (1.00s)
46.932	17.1	V	40.0	-22.9	QP	257	1.0	QP (1.00s)
39.690	16.4	V	40.0	-23.6	QP	245	1.5	QP (1.00s)
933.456	17.0	H	46.0	-29.0	QP	163	4.0	QP (1.00s)



EMC Test Data

Client:	Intel Corporation	Job Number:	J80398
Model:	Intel® Centrino® Advanced-N 6230	T-Log Number:	T80540
Contact:	Steve Hackett	Account Manager:	Christine Krebill
Standard:	FCC 15.247	Class:	B

Conducted Emissions - JBP (Digital Device, Card Installed in PC)

(Elliott Laboratories Fremont Facility, Semi-Anechoic Chamber)

Test Specific Details

Objective: The objective of this test session is to perform final qualification testing of the EUT with respect to the specification listed above.

Date of Test: 9/22/2010 Config. Used: JBP
Test Engineer: Peter Sales Config Change: None
Test Location: Fremont Chamber #3 Host Unit Voltage 120V/60Hz

General Test Configuration

The host laptop was located on a wooden table inside the semi-anechoic chamber, 40 cm from a vertical coupling plane and 80cm from the LISN. A second LISN was used for all local support equipment. Remote support equipment was located outside of the semi-anechoic chamber. Any cables running to remote support equipment were routed through metal conduit and when possible passed through a ferrite clamp upon exiting the chamber.

Ambient Conditions: Temperature: 23 °C
Rel. Humidity: 48 %

Summary of Results

Run #	Test Performed	Limit	Result	Margin
1	CE, AC Power, 120V/60Hz	Class B	Pass	44.7dB _U V @ 1.900MHz (-11.3dB)

Modifications Made During Testing

No modifications were made to the EUT during testing

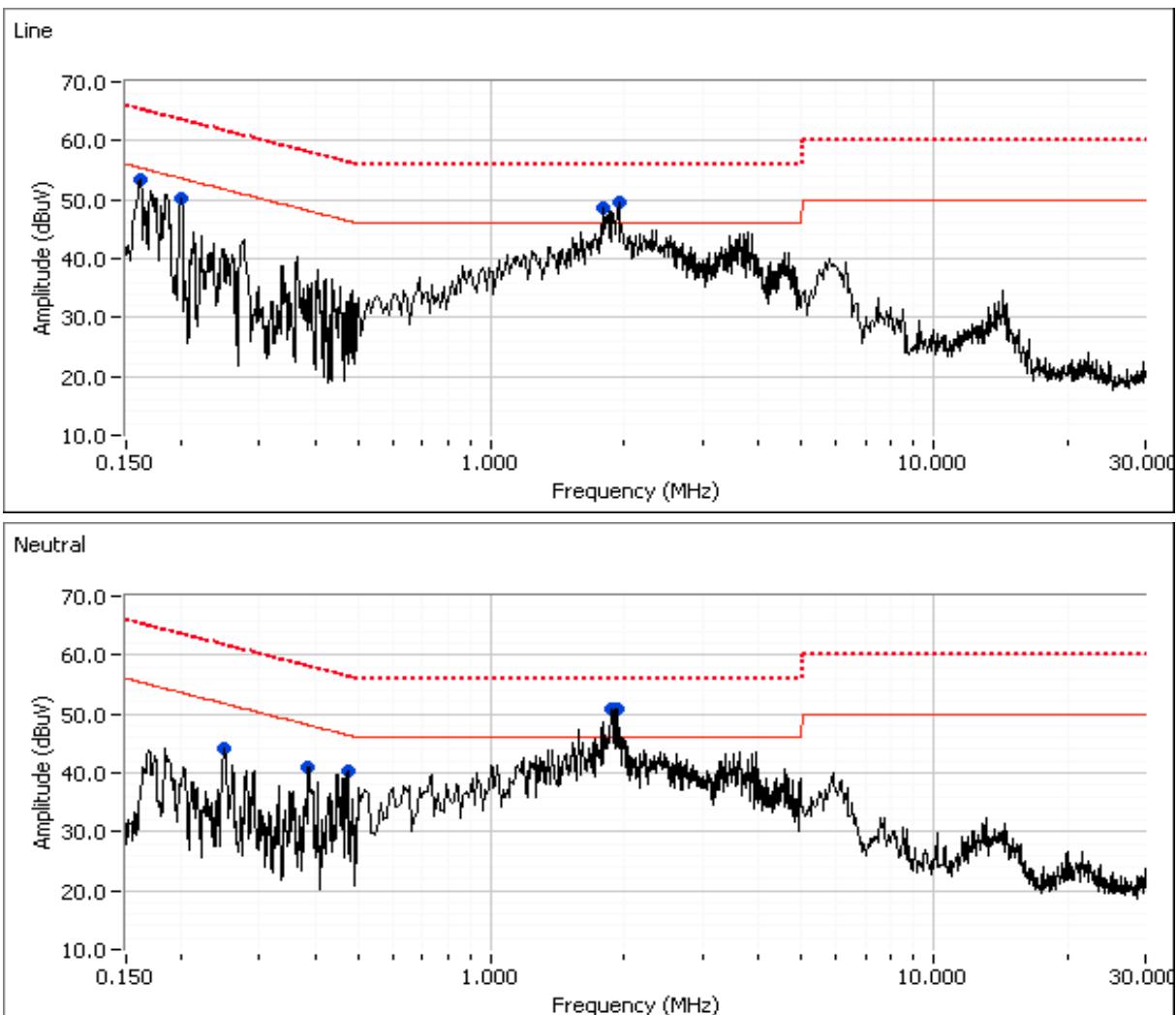
Deviations From The Standard

No deviations were made from the requirements of the standard.

Client:	Intel Corporation	Job Number:	J80398
Model:	Intel® Centrino® Advanced-N 6230	T-Log Number:	T80540
Contact:	Steve Hackett	Account Manager:	Christine Krebill
Standard:	FCC 15.247	Class:	B

Run #1: AC Power Port Conducted Emissions, 0.15 - 30MHz, 120/60Hz

Preliminary peak readings captured during pre-scan (peak readings vs. average limit)



Continue Run #1 next page...



EMC Test Data

Client:	Intel Corporation	Job Number:	J80398
Model:	Intel® Centrino® Advanced-N 6230	T-Log Number:	T80540
Contact:	Steve Hackett	Account Manager:	Christine Krebill
Standard:	FCC 15.247	Class:	B

Run #1: AC Power Port Conducted Emissions, 0.15 - 30MHz, 120/60Hz (continue)

Frequency MHz	Level dB μ V	AC Line	Class B		Detector QP/Ave	Comments
			Limit	Margin		
1.886	50.9	Neutral	46.0	4.9	Peak	
1.900	50.8	Neutral	46.0	4.8	Peak	
1.927	49.6	Line 1	46.0	3.6	Peak	
1.796	48.6	Line 1	46.0	2.6	Peak	
0.161	53.4	Line 1	55.4	-2.0	Peak	
0.198	50.1	Line 1	53.6	-3.5	Peak	
0.474	40.3	Neutral	46.4	-6.1	Peak	
0.386	41.0	Neutral	48.1	-7.1	Peak	
0.249	44.3	Neutral	51.8	-7.5	Peak	

Final quasi-peak and average readings

Frequency MHz	Level dB μ V	AC Line	Class B		Detector QP/Ave	Comments
			Limit	Margin		
1.900	44.7	Neutral	56.0	-11.3	QP	QP (1.00s)
1.886	44.5	Neutral	56.0	-11.5	QP	QP (1.00s)
1.927	44.3	Line 1	56.0	-11.7	QP	QP (1.00s)
1.900	32.5	Neutral	46.0	-13.5	AVG	AVG (0.10s)
1.796	42.4	Line 1	56.0	-13.6	QP	QP (1.00s)
1.927	32.2	Line 1	46.0	-13.8	AVG	AVG (0.10s)
1.886	31.6	Neutral	46.0	-14.4	AVG	AVG (0.10s)
1.796	30.9	Line 1	46.0	-15.1	AVG	AVG (0.10s)
0.161	48.7	Line 1	65.4	-16.7	QP	QP (1.00s)
0.198	46.2	Line 1	63.7	-17.5	QP	QP (1.00s)
0.249	42.1	Neutral	61.8	-19.7	QP	QP (1.00s)
0.474	34.7	Neutral	56.4	-21.7	QP	QP (1.00s)
0.386	34.6	Neutral	58.1	-23.5	QP	QP (1.00s)
0.161	30.1	Line 1	55.4	-25.3	AVG	AVG (0.10s)
0.386	20.1	Neutral	48.1	-28.0	AVG	AVG (0.10s)
0.249	23.3	Neutral	51.8	-28.5	AVG	AVG (0.10s)
0.198	24.6	Line 1	53.7	-29.1	AVG	AVG (0.10s)
0.474	16.7	Neutral	46.4	-29.7	AVG	AVG (0.10s)

Appendix C Test Configuration Photographs

Uploaded as a separate exhibit

Appendix D Basic and Reference Standards

Subpart B of Part 15 of FCC Rules for digital devices.

FCC Part 15 Subpart B references the use of ANSI C63.4–2003: “*Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz*” for the purposes of evaluating the radiated and conducted emissions from digital devices.